

● General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

● Features

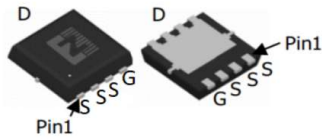
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low thermal resistance
- AEC-Q101 qualified

● Application

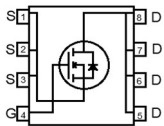
- BLDC motor driver
- DC-DC
- Load switch



● Product Summary



DFN3*3



$V_{DS}=60V$

$R_{DS(ON)}=5.2mR$

$I_D=112A$



● Ordering Information

Part NO.	ZMSA050N06HMC
Marking	050N06H
Packing information	REEL TAPE
Basic ordering unit (pcs)	5000

● Absolute Maximum Ratings ($T_A=25^{\circ}C$, unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Max.	Unit
Drain-source voltage	V_{DS}		-	60	V
Gate-source voltage ^①	V_{GS}		-20	20	V
Continuous drain current	I_D	$V_{GS}=10V, T_C=25^{\circ}C$	-	112	A
	I_D	$V_{GS}=10V, T_C=75^{\circ}C$	-	91	A
	I_D	$V_{GS}=10V, T_C=100^{\circ}C$	-	79	A
Pulsed drain current ^①	I_{DM}	Pulsed, $t_p \leq 10 \mu s, T_C = 25^{\circ}C$	-	448	A
Diode continuous current	I_S	$V_{GS}=0V, T_C=25^{\circ}C$	-	112	A
Diode pulse current	$I_{S,pulse}$	$V_{GS}=0V$, Pulsed, $t_p \leq 10 \mu s, T_C = 25^{\circ}C$	-	448	A
Total power dissipation	P_D	$T_C=25^{\circ}C$	-	155	W
Total power dissipation	P_D	$T_A=25^{\circ}C$	-	2.5	W
Operating junction temperature	T_J		-55	175	$^{\circ}C$
Storage temperature	T_{STG}		-55	175	$^{\circ}C$
Single pulse avalanche energy	E_{AS}	$L=0.1mH, V_{GS}=10V, R_g=25\Omega$	-	65	mJ

Single pulse avalanche energy	E_{AS}	$L=0.5mH, V_{GS}=10V, R_g=25\Omega$	-	117	mJ
ESD level (HBM)	CLASS 2				

● Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	0.97	°C/W
Thermal resistance, junction - ambient	$R_{thJA}^{(2)}$	-	-	60	°C/W
Soldering temperature	T_{sld}	-	-	260	°C

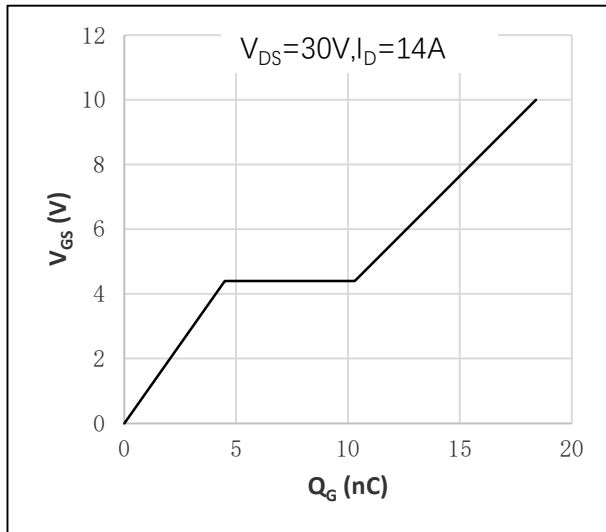
● Electronic Characteristics ($T_J=25^\circ C$, unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	60	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2	2.7	4	V
Drain-source leakage current	I_{DSS}	$V_{GS}=0V, V_{DS}=60V$	-	-	1	μA
Gate- source leakage current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	100	nA
Static drain-source on resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=14A, T_J=25^\circ C$	-	5.2	6.2	m Ω
		$V_{GS}=10V, I_D=14A, T_J=175^\circ C$	-	10.4	-	m Ω
Forward transconductance	g_{FS}	$V_{DS}=5V, I_{SD}=10A$	-	10	-	S
Diode forward voltage	V_{FSD}	$V_{GS}=0V, I_{SD}=14A$	-	0.8	1.3	V

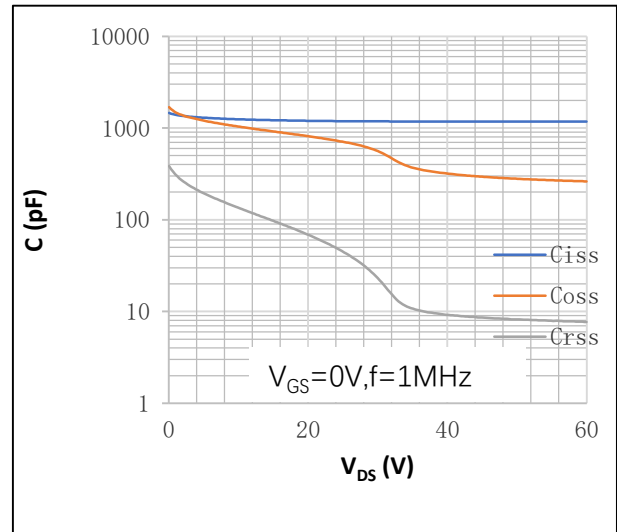
● Dynamic characteristics ($T_J=25^\circ C$, unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$f=1MHz, V_{DS}=30V, V_{GS}=0V$	-	1207	-	pF
Output capacitance	C_{oss}		-	508	-	pF
Reverse transfer capacitance	C_{rss}		-	27	-	pF
Gate resistance	R_g	$f=1MHz$	-	1.4	-	Ω
Total gate charge	Q_g	$V_{DD}=30V, I_D=14A, V_{GS}=10V$	-	18.4	-	nC
Gate-source charge	Q_{gs}		-	4.5	-	nC
Gate-drain charge	Q_{gd}		-	5.8	-	nC
Turn-on delay time	$t_{D(on)}$	$V_{GS}=10V, V_{DS}=30V, R_G=3.3\Omega, I_D=14A$	-	5	-	ns
Turn-on rise time	t_r		-	3	-	ns
Turn-off delay time	$t_{D(off)}$		-	15	-	ns
Turn-off fall time	t_f		-	3	-	ns
Reverse recovery time	t_{rr}	$V_{DD}=30V, dI_S/dt=100A/\mu s, I_S=14A$	-	19	-	ns
Reverse recovery charge	Q_{rr}		-	7	-	nC

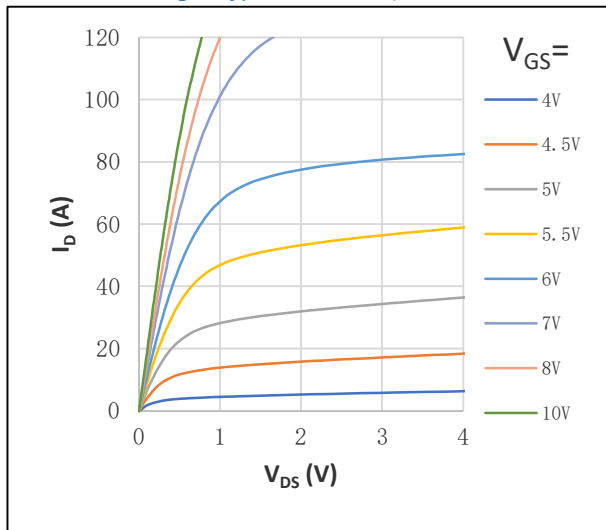
● Fig.1 Gate-source voltage as a function of gate charge; Typical values; $T_j=25^\circ\text{C}$



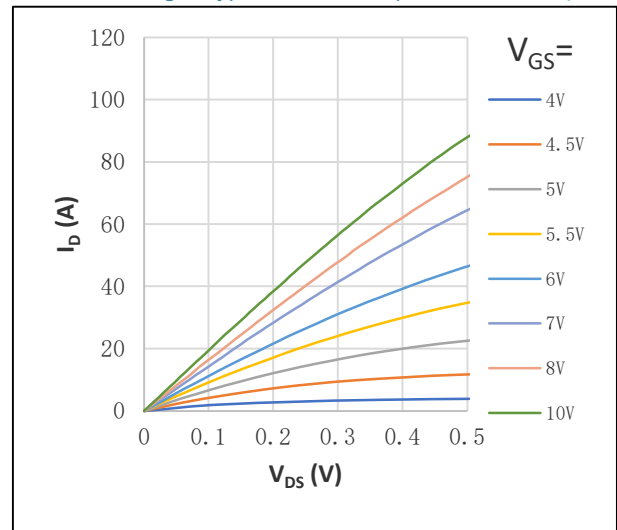
● Fig.2 Input, output and reverse transfer capacitances as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$



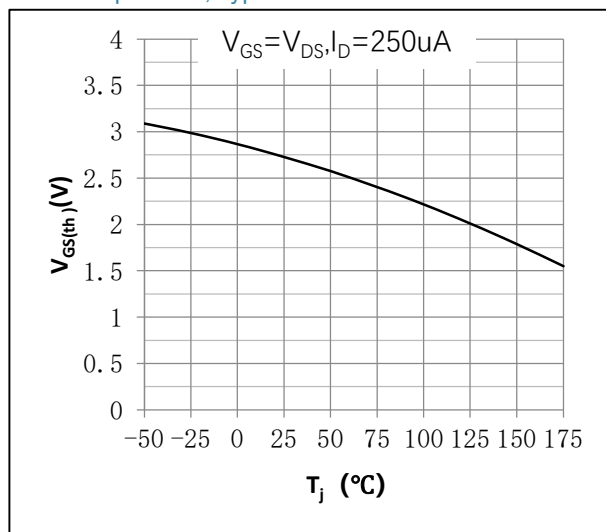
● Fig.3 Output characteristics: drain current as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$



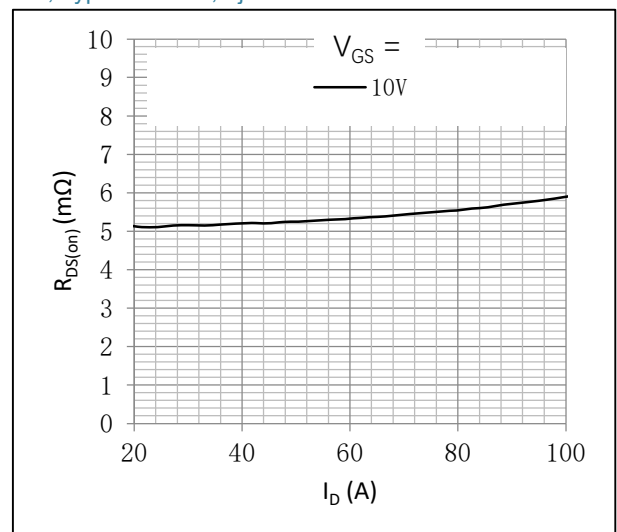
● Fig.4 Output characteristics: drain current as a function of drain-source voltage; Typical values: Expanded curve; $T_j=25^\circ\text{C}$



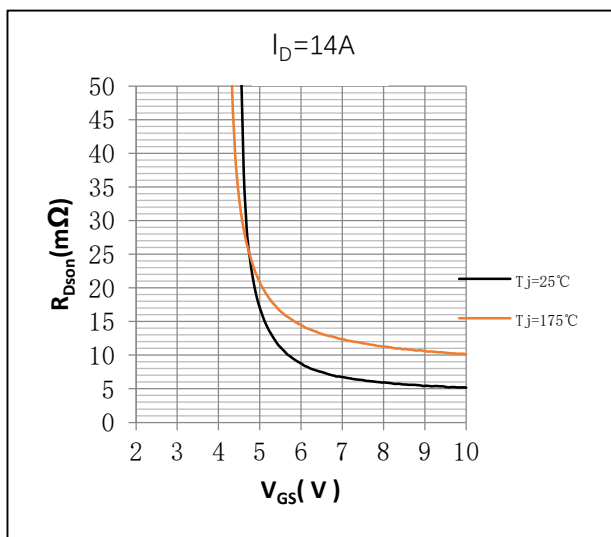
● Fig.5 Gate-source threshold voltage as a function of junction temperature; Typical values



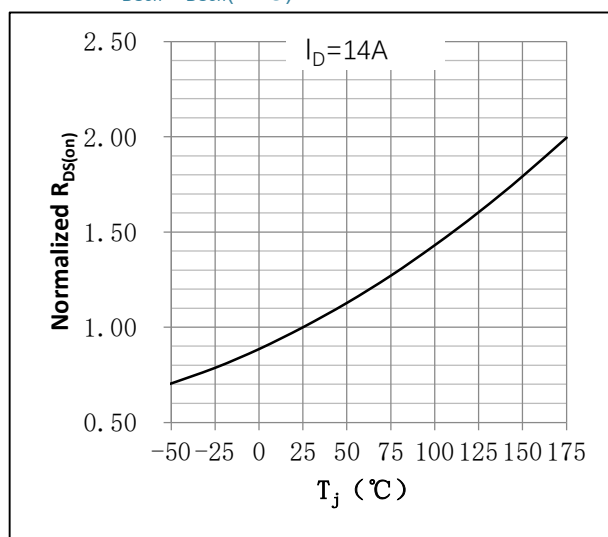
● Fig.6 Drain-source on-state resistance as a function of drain current; Typical values; $T_j=25^\circ\text{C}$



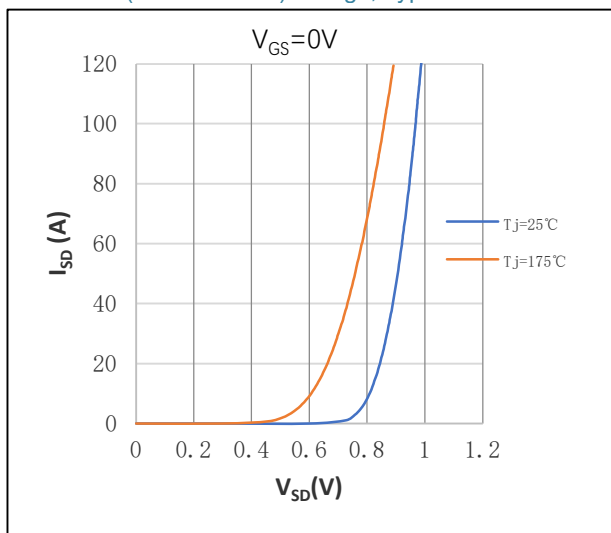
● Fig.7 Drain-source on-state resistance as a function of gate-source voltage; Typical values



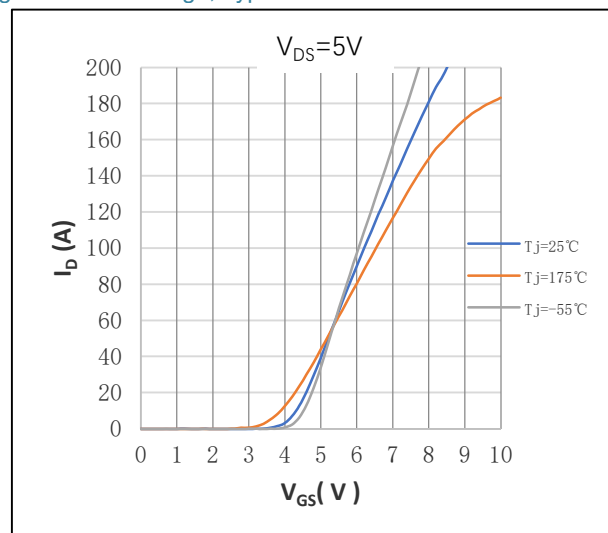
● Fig.8 Normalized drain-source on-state resistance factor as a function of junction temperature; Typical values Normalized On-Resistance= $R_{DS(on)}/R_{DS(on)}(25^\circ C)$



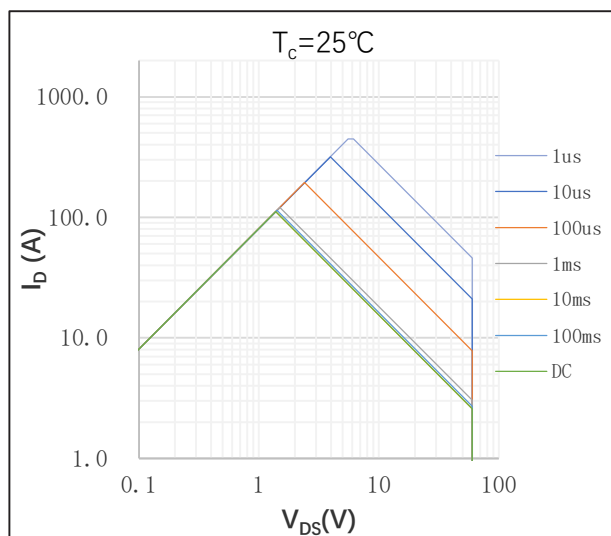
● Figure 9. Source (diode forward) current as a function of source-drain (diode forward) voltage; Typical values



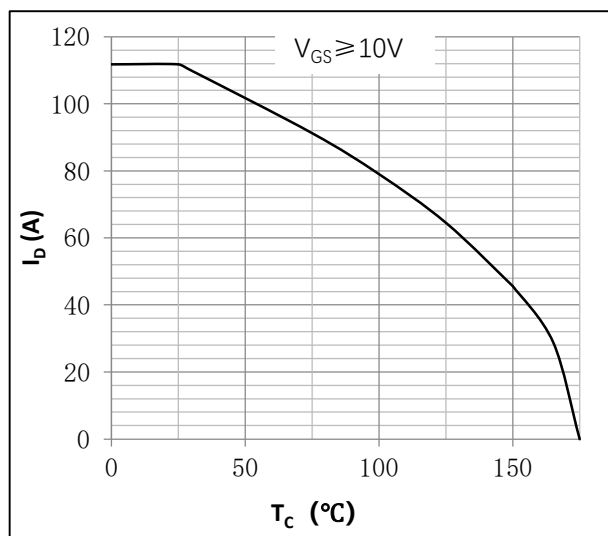
● Figure 10. Transfer characteristics: drain current as a function of gate-source voltage; Typical values



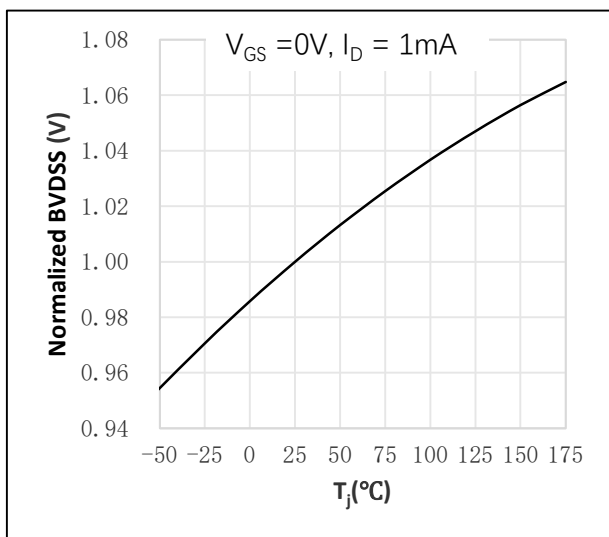
● Fig.11 Safe operating area: continuous and peak drain currents as a function of drain-source voltage; Calculative values



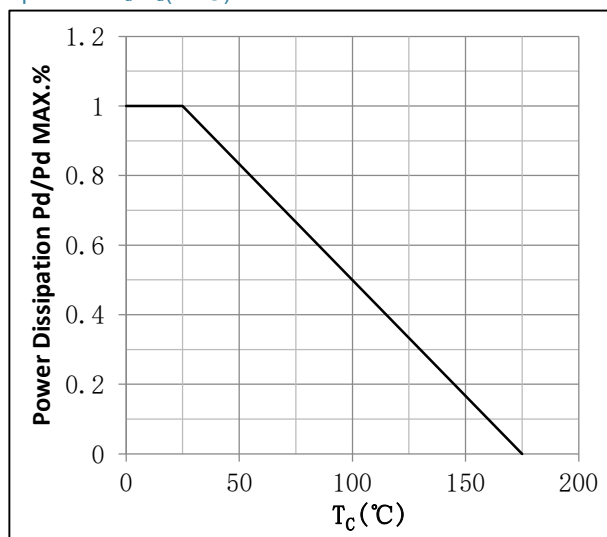
● Fig.12 Continuous drain current as a function of case temperature³; Calculative values



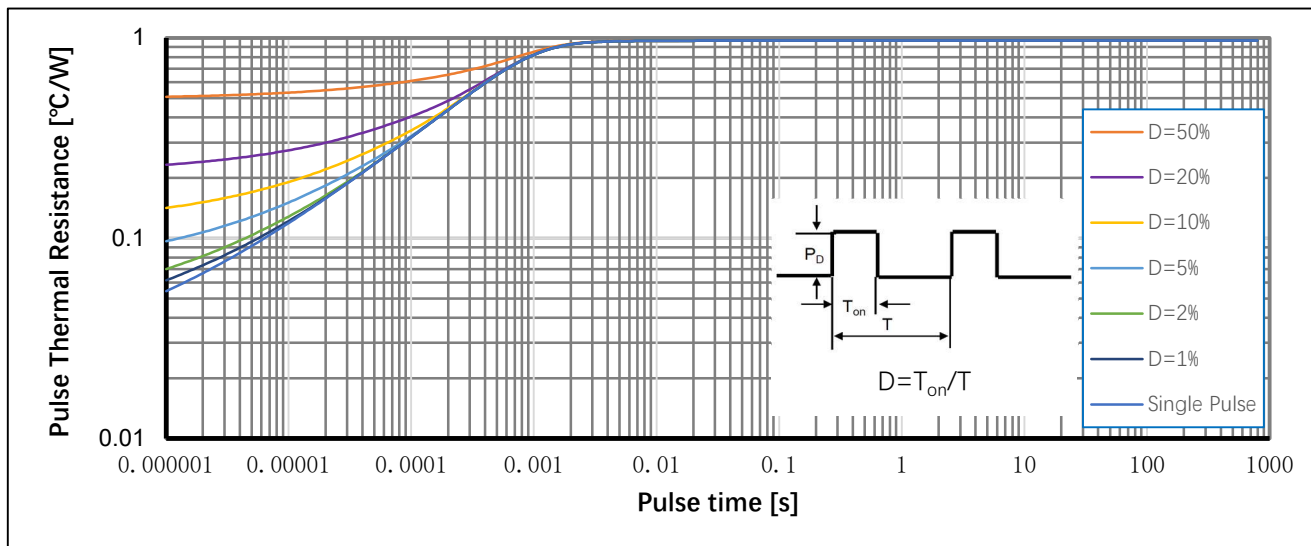
● Fig.13 Drain-source breakdown voltage as a function of junction temperature; Typical values



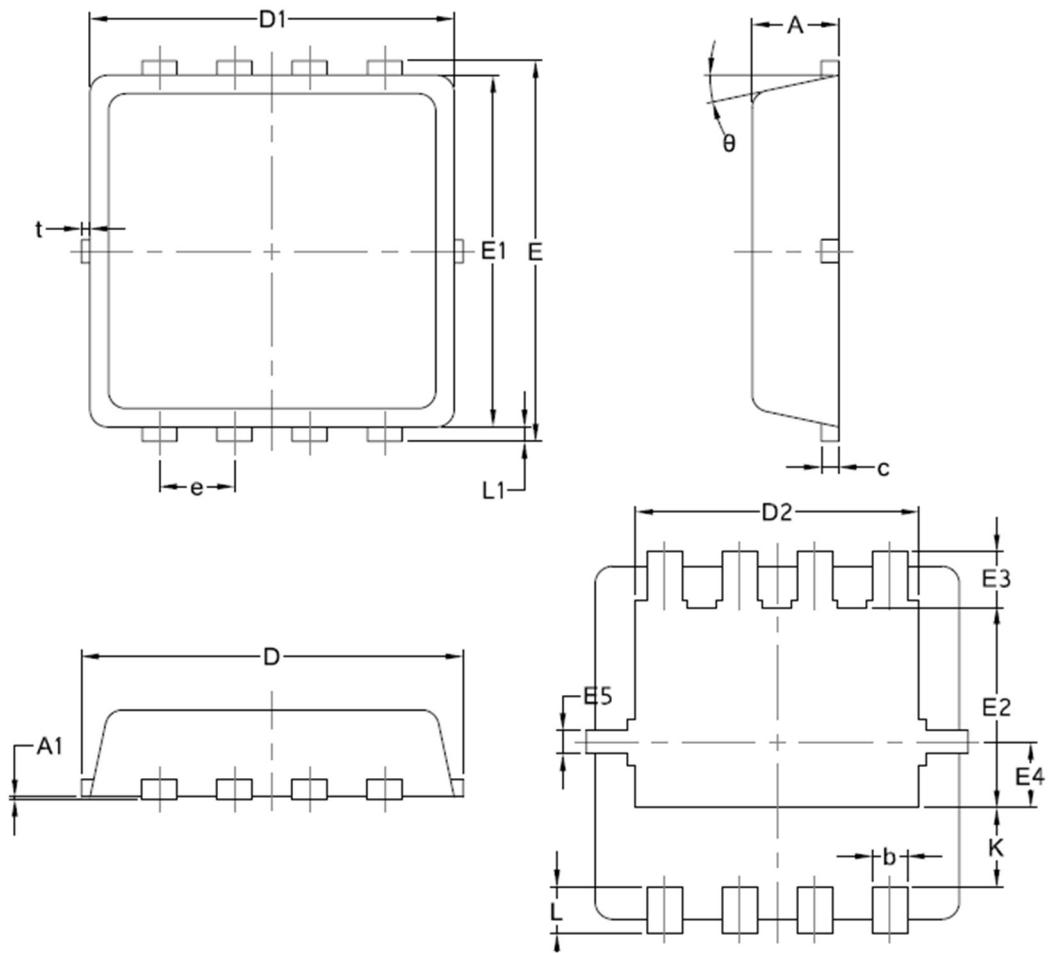
● Fig.14 Normalized total power dissipation as a function of case temperature; Calculative values Normalized Power Dissipation = $P_d/P_d(25^{\circ}C)$



● Fig.15 Transient thermal impedance from junction to case as a function of pulse duration; max values



● Package Outline



S Y M B O L	COMMON		
	MM		
	MIN	NOM	MAX
A	0.70	0.75	0.85
A1	/	/	0.05
b	0.20	0.30	0.40
c	0.10	0.152	0.25
D	3.15	3.30	3.45
△ 2 D1	3.00	3.15	3.25
△ 2 D2	2.29	2.45	2.65
E	3.15	3.30	3.45
E1	2.90	3.05	3.20
E2	1.54	1.74	1.94
△ 3 E3	0.28	0.48	0.65
E4	0.37	0.57	0.77
E5	0.10	0.20	0.30
e	0.60	0.65	0.70
△ 2 K	0.59	0.69	0.89
L	0.30	0.40	0.50
L1	0.06	0.125	0.20
△ 2 t	0	0.075	0.13
△ 2 θ	10°	12°	14°

● Note

- ① Pulse : $V_{GS}=+20V/-20V$, Duty cycle=50%, $T_j=175^{\circ}C$, $t=1000$ hours; For DC , the following test conditions can be passed: $V_{GS}=+20V/-10V$, $T_j=175^{\circ}C$, $t=1000$ hours;
- ② Device mounted on 1 square inch FR-4 substrate PCB, 1oz copper, minimum footprint, tested in a still air environment with $T_A=25^{\circ}C$;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS}=10V$.

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● Revision History

Version	Date	Change
A	2025/10/11	New